

<b>Notice of References Cited</b>	Application/Control No. 10/766,478		Applicant(s)/Patent Under Reexamination FITZ, HELMUT	
	Examiner Hanh V. Tran		Art Unit 3637	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2,239,734 A	04-1941	PRATT DON W	312/238
*	B	US-3,075,820 A	01-1963	HUMPHREY DAVID H	312/326
*	C	US-3,160,453 A	12-1964	TASSELL LESLIE E	312/238
*	D	US-4,090,753 A	05-1978	Rock et al.	312/140
*	E	US-4,146,280 A	03-1979	Crownhart, Maurice	312/305
*	F	US-4,433,885 A	02-1984	Baker, Clayton C.	312/305
*	G	US-4,440,459 A	04-1984	Hallgren, Charles G.	312/238
*	H	US-4,995,683 A	02-1991	Albiez, Alfred	312/348.4
*	I	US-5,249,856 A	10-1993	Dreier, Horst	312/238
*	J	US-5,662,398 A	09-1997	Swallow, Clarence	312/238
*	K	US-6,561,605 B1	05-2003	Akers, Paul	312/348.1
*	L	US-6,609,774 B2	08-2003	Banicevic et al.	312/330.1
*	M	US-6,961,988 B2	11-2005	Koons, Bill J.	29/525.11

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	2003070574	03-2003	Japan	Yoshida et al	
	O	451737	10-1991	Europe	Kneile	312/238
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.